

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination CHANG, SUNG-SAN	
		Examiner Henok G. Heyi	Art Unit 2609	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,123,005 A	06-1992	Kurosu, Tadao	720/602
*	B	US-6,005,833 A	12-1999	Yasuma et al.	720/602
*	C	US-6,311,613 B1	11-2001	Takahashi, Mituru	101/118
*	D	US-6,378,860 B1	04-2002	Gutierrez et al.	271/217
*	E	US-6,370,100 B2	04-2002	Koshino et al.	720/602
*	F	US-6,643,240 B2	11-2003	Chen, Ling-Feng	369/53.3
*	G	US-2005/0204373 A1	09-2005	Ueno et al.	720/616
*	H	US-2006/0161929 A1	07-2006	De Hoog et al.	720/602
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.